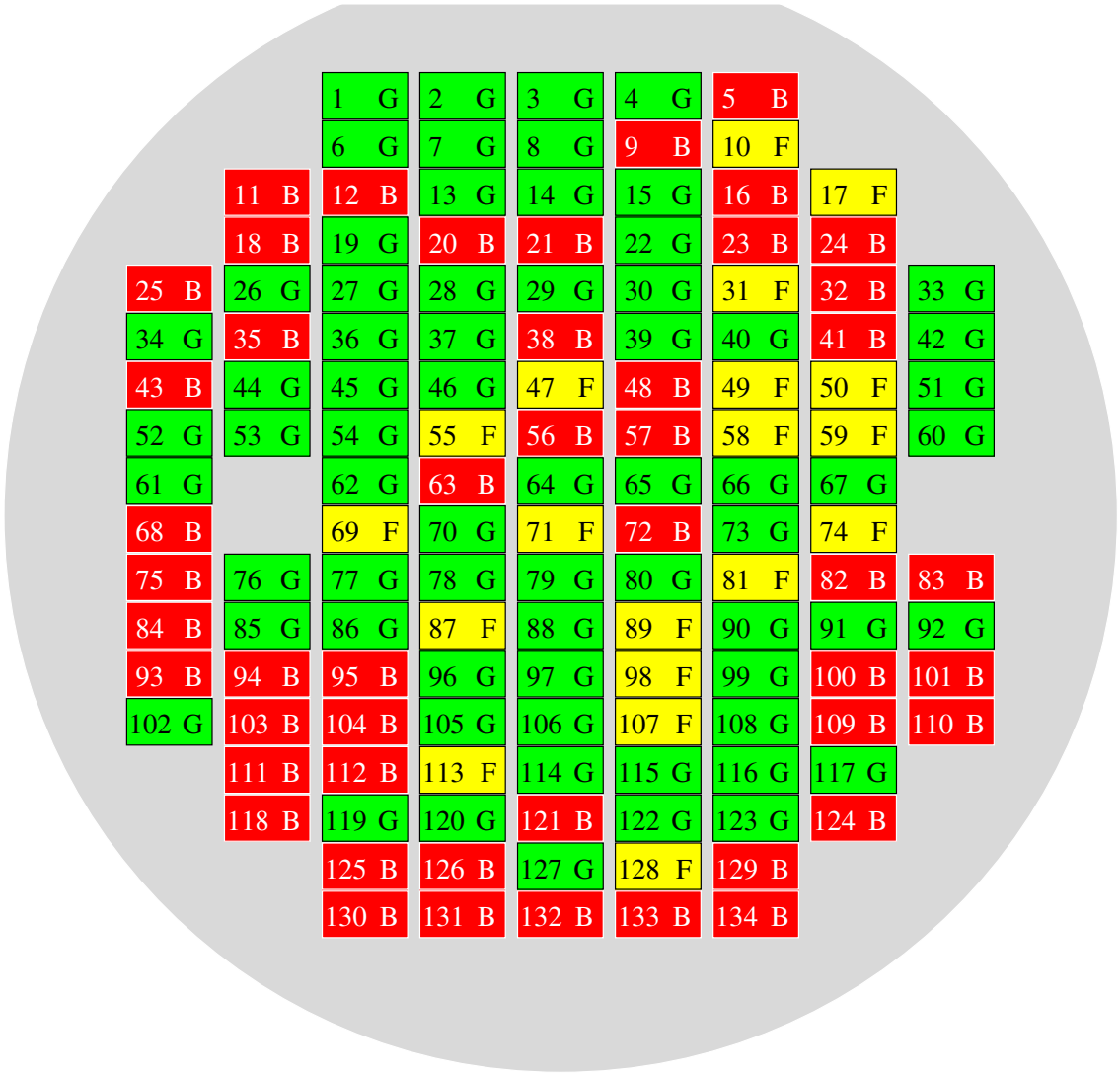
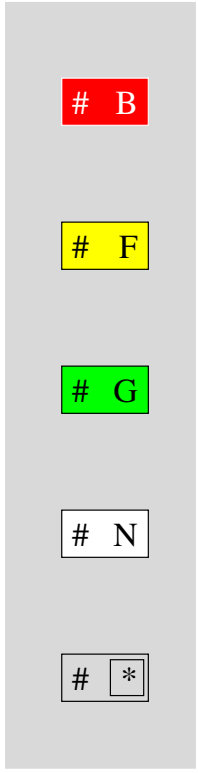
Die quality map for wafer 202 s/n: 21316-14-10

Date: 10/07/99





Bad die

Fair die

Good die

No info

Manually tagged